

<b>Notice of References Cited</b>	Application/Control No. 10/715,871	Applicant(s)/Patent Under Reexamination EPLEY, JOHN M.	
	Examiner Jeffrey G. Hoekstra	Art Unit 3736	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,159,171	12-2000	Densert et al.	601/76
*	B	US-6,314,324	11-2001	Lattner et al.	607/42
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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**NON-PATENT DOCUMENTS**

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